

Data Sheet

September 1998

File Number

2914.3

# 150MHz, Fast Settling Operational **Amplifiers**

HA-5190/5195 are operational amplifiers featuring a combination of speed, precision, and bandwidth. Employing monolithic bipolar construction coupled with Dielectric Isolation, these devices are capable of delivering 200V/µs slew rate with a settling time of 70ns (0.1%, 5V output step). These truly differential amplifiers are designed to operate at gains ≥ 5 without the need for external compensation. Other outstanding HA-5190/5195 features are 150MHz gain bandwidth product and 6.5MHz full power bandwidth. In addition to these dynamic characteristics, these amplifiers also have excellent input characteristics such as 3mV offset voltage and 6.0nV/√Hz input voltage noise at 1kHz.

With 200V/us slew rate and 70ns settling time, these devices make ideal output amplifiers for accurate, high speed D/A converters or the main components in high speed sample/hold circuits. The 5190/5195 are also ideally suited for a variety of pulse and wideband video amplifiers. Please refer to Application Notes AN525 and AN526 for some of these application designs.

At temperatures above 75°C a heat sink is required for the HA-5190 (see Note 2 and Application Note AN556). For military versions, please request the HA-5190/883 data sheet.

#### **Features**

• Fast Settling Time (0.1%) 70ns
• Very High Slew Rate
• Wide Gain-Bandwidth (A <sub>V</sub> ≥ 5)
Full Power Bandwidth
Low Offset Voltage
• Input Noise Voltage 6nV/\(\overline{Hz}\)

· Bipolar D.I. Construction

# **Applications**

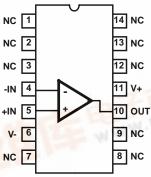
- Fast, Precise D/A Converters
- High Speed Sample-Hold Circuits
- Pulse and Video Amplifiers
- · Wideband Amplifiers

# **Ordering Information**

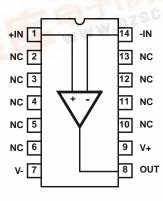
PART NUMBER	TEMP. RANGE (°C)	PACKAGE	PKG. NO.
HA1-5190-2	-55 to 125	14 Ld CERDIP	F14.3
HA1-5195-5	0 to 75	14 Ld CERDIP	F14.3
HA9P5195-5	0 to 75	14 Ld SOIC	M14.15

#### **Pinouts**





#### HA-5195 (SOIC) TOP VIEW





# HA-5190, HA-5195

# **Absolute Maximum Ratings** $T_A = 25^{\circ}C$

# Supply Voltage (V+ to V-) 35V Differential Input Voltage 6V Output Current 50mA (Peak)

# **Operating Conditions**

Temperature Range	
HA-5190-2	55°C to 125°C
HA-5195-5	0°C to 75°C

#### **Thermal Information**

Thermal Resistance (Typical, Note 2)	θ <sub>JA</sub> ( <sup>o</sup> C/W)	θ <sub>JC</sub> ( <sup>o</sup> C/W)
CERDIP Package	75	20
SOIC Package	119	N/A
Maximum Junction Temperature (Hermetic		e 1)175 <sup>0</sup> C
Maximum Junction Temperature (Plastic I	Package, Note	1)150 <sup>o</sup> C
Maximum Storage Temperature Range	65	<sup>o</sup> C to 150 <sup>o</sup> C
Maximum Lead Temperature (Soldering 1	0s)	300°C
(SOIC Lead Tips Only)		

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

#### NOTES:

- 1. Heat sinking may be required, especially at  $T_A \ge 75^{\circ}C$ .
- 2.  $\theta_{\mbox{\scriptsize JA}}$  is measured with the component mounted on an evaluation PC board in free air.

#### **Electrical Specifications** $V_{SUPPLY} = \pm 15V$ , Unless Otherwise Specified

PARAMETER	TEST CONDITIONS	TEMP (°C)	HA-5190-2			HA-5195-5			
			MIN	TYP	MAX	MIN	TYP	MAX	UNITS
INPUT CHARACTERISTICS									•
Offset Voltage		25	-	3	5	-	3	6	mV
		Full	-	-	10	-	-	10	mV
Average Offset Voltage Drift		Full	-	20	-	-	20	-	μV/ <sup>o</sup> C
Bias Current		25	-	5	15	-	5	15	μΑ
		Full	-	-	20	-	-	20	μΑ
Offset Current		25	-	1	4	-	1	4	μА
		Full	-	-	6	-	-	6	μА
Input Resistance		25	-	10	-	-	10	-	kΩ
Input Capacitance		25	-	1	-	-	1	-	pF
Common Mode Range		Full	±5	-	-	±5	-	-	V
Input Noise Current	$f = 1kHz, R_G = 0\Omega$	25	-	5	-	-	5	-	pA/√H
Input Noise Voltage	$f = 1kHz, R_G = 0\Omega$	25	-	6	-	-	6	-	nV/√H
TRANSFER CHARACTERISTICS					-				
Large Signal Voltage Gain (Note 3)		25	15	30	-	10	30	-	kV/V
		Full	5	-	-	5	-	-	kV/V
Common Mode Rejection Ratio	$\Delta V_{CM} = \pm 5V$	Full	74	95	-	74	95	-	dB
Minimum Stable Gain		25	5	-	-	5	-	-	V/V
Gain-Bandwidth-Product	V <sub>OUT</sub> = 90mV, A <sub>V</sub> = 10	25	-	150	-	150	-	-	MHz
OUTPUT CHARACTERISTICS									
Output Voltage Swing (Note 3)		Full	±5	±8	-	±5	±8	-	V
Output Current (Note 3)		25	±25	±30	-	±25	±30	-	mA
Output Resistance	Open Loop	25	-	30	-	-	30	-	Ω
Full Power Bandwidth (Notes 3, 4)		25	5	6.5	-	5	6.5	-	MHz
TRANSIENT RESPONSE (Note 5)	1			1					
Rise Time		25	-	13	18	-	13	18	ns
Overshoot		25	-	8	-	-	8	-	%
Slew Rate		25	160	200	-	160	200	-	V/μs
Settling Time (Note 5)	5V Step to 0.1%	25	70	-	-	70	-	-	ns
	5V Step to 0.01%	25	-	100	-	-	100	-	ns
	2.5V Step to 0.1%	25	-	50	-	-	50	-	ns
	2.5V Step to 0.01%	25	_	80	_	_	80	<u> </u>	ns

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#### HA-5190, HA-5195

# **Electrical Specifications** $V_{SUPPLY} = \pm 15V$ , Unless Otherwise Specified (Continued)

	TEST		HA-5190-2			HA-5195-5			
PARAMETER	CONDITIONS	TEMP (°C)	MIN	TYP	MAX	MIN	TYP	MAX	UNITS
POWER SUPPLY CHARACTERISTICS									
Supply Current		Full	=	19	28	-	19	28	mA
Power Supply Rejection Ratio	$\Delta V_S = \pm 10 \text{V to } \pm 20 \text{V}$	Full	70	90	-	70	90	-	dB

#### NOTES:

- 3.  $R_L = 200\Omega$ ,  $C_L < 10pF$ ,  $V_{OUT} = \pm 5V$ .
- 4. Full power bandwidth guaranteed based on slew rate measurement using: FPBW =  $\frac{\text{Slew Rate}}{2\pi V_{\text{PEAK}}}$
- 5. Refer to Test Circuits section of the data sheet.

### Test Circuits and Waveforms

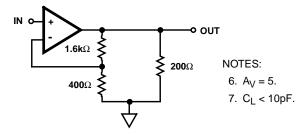
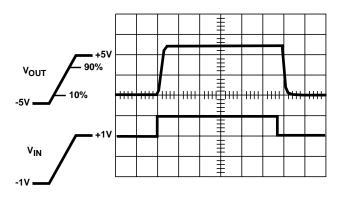
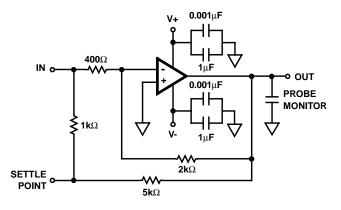


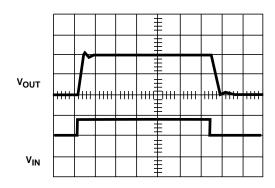
FIGURE 1. LARGE AND SMALL SIGNAL RESPONSE TEST CIRCUIT



Vertical Scale:  $V_{IN} = 2.0V/Div., V_{OUT} = 4.0/Div.$ Horizontal Scale: 100ns/Div.

#### LARGE SIGNAL RESPONSE





 $\label{eq:Volume} \textit{Vertical Scale: } V_{\mbox{\footnotesize{IN}}} = 50 \mbox{\footnotesize{mV/Div.}}, \ V_{\mbox{\footnotesize{OUT}}} = 100 \mbox{\footnotesize{mV/Div.}}$ Horizontal Scale: 100ns/Div

#### **SMALL SIGNAL RESPONSE**

#### NOTES:

- 8.  $A_V = -5$ .
- 9. Load Capacitance should be less than 10pF.
- 10. It is recommended that resistors be carbon composition and that feedback and summing network ratios be matched to 0.1%.
- 11. Settle Point (Summing Node) capacitance should be less than 10pF. For optimum settling time results, it is recommended that the test circuit be constructed directly onto the device pins. A Tektronix 568 Sampling Oscilloscope with S-3A sampling heads is recommended as a settle point monitor.

FIGURE 2. SETTLING TIME TEST CIRCUIT

# Schematic Diagram

# **Application Information**

#### **Power Supply Decoupling**

Although not absolutely necessary, it is recommended that all power supply lines be decoupled with 0.01µF ceramic capacitors to ground. Decoupling capacitors should be located as near to the amplifier terminals as possible.

#### Stability Considerations

HA-5190/5195 is stable at gains > 5. Gains < 5 are covered below. Feedback resistors should be of carbon composition located as near to the input terminals as possible.

#### Wiring Considerations

Video pulse circuits should be built on a ground plane. Minimum point to point connections directly to the amplifier terminals should be used. When ground planes cannot be used, good single point grounding techniques should be applied.

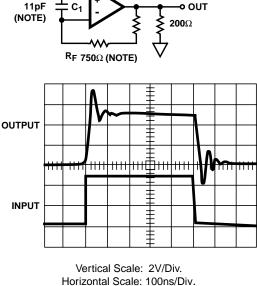
#### **Output Short Circuit**

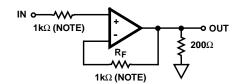
HA-5190/5195 does not have output short circuit protection. Short circuits to ground can be tolerated for approximately 10 seconds. Short circuits to either supply will result in immediate destruction of the device.

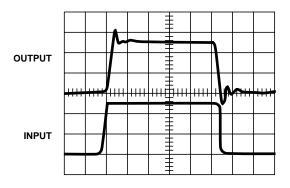
#### Heavy Capacitive Loads

When driving heavy capacitive loads (>100pF) a small resistor (100 $\Omega$ ) should be connected in series with the output and inside the feedback loop.

#### **Typical Applications** (Also see Application Notes AN525 and AN526)





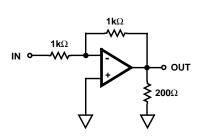


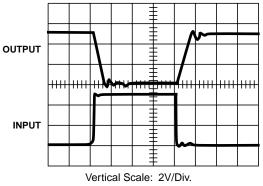
Vertical Scale: 2V/Div. Horizontal Scale: 100ns/Div

NOTE: Values were determined experimentally for optimum speed and settling time. RF and C1 should be optimized for each particular application to ensure best overall frequency response.

FIGURE 3. SUGGESTED COMPENSATION FOR NONINVERTING UNITY GAIN AMPLIFIER

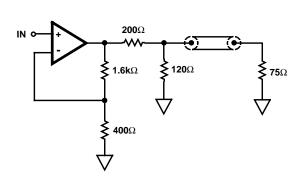
# Typical Applications (Also see Application Notes AN525 and AN526) (Continued)





Horizontal Scale: 50ns/Div.

FIGURE 4. SUGGESTED COMPENSATION FOR INVERTING UNITY GAIN AMPLIFIER



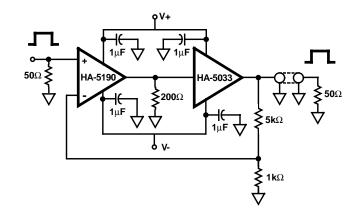


FIGURE 5. VIDEO PULSE AMPLIFIER/75  $\Omega$  COAXIAL DRIVER

FIGURE 6. VIDEO PULSE AMPLIFIER COAXIAL LINE DRIVER

# **Typical Performance Curves** $V_S = \pm 15V$ , $T_A = 25^{\circ}C$ , Unless Otherwise Specified

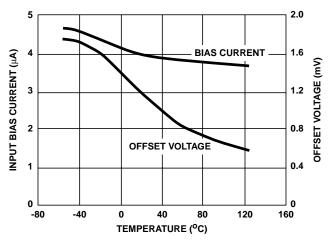


FIGURE 7. INPUT OFFSET VOLTAGE AND BIAS CURRENT vs TEMPERATURE

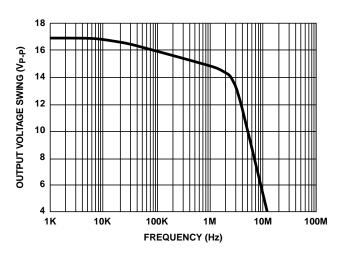


FIGURE 9. OUTPUT VOLTAGE SWING vs FREQUENCY

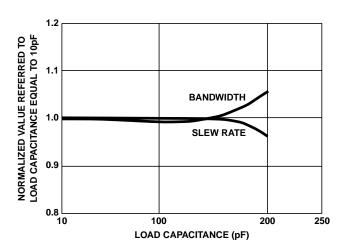


FIGURE 11. NORMALIZED AC PARAMETERS vs LOAD CAPACITANCE

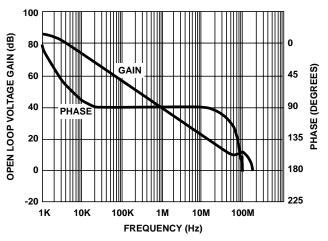


FIGURE 8. OPEN LOOP FREQUENCY RESPONSE

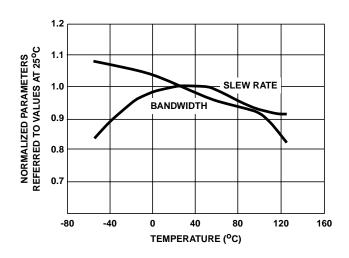


FIGURE 10. NORMALIZED AC PARAMETERS vs TEMPERATURE

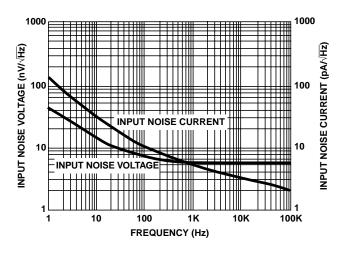


FIGURE 12. INPUT NOISE VOLTAGE AND NOISE CURRENT vs FREQUENCY

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# $\textit{Typical Performance Curves} \quad \text{V}_{S} = \pm 15 \text{V}, \text{ T}_{A} = 25^{o}\text{C}, \text{ Unless Otherwise Specified} \quad \textit{\textbf{(Continued)}}$

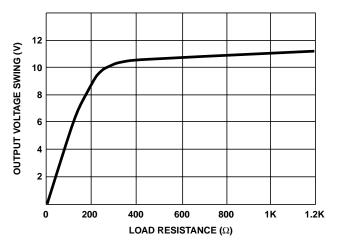


FIGURE 13. OUTPUT VOLTAGE SWING vs LOAD RESISTANCE

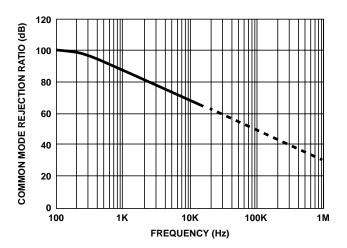


FIGURE 15. COMMON MODE REJECTION RATIO vs FREQUENCY

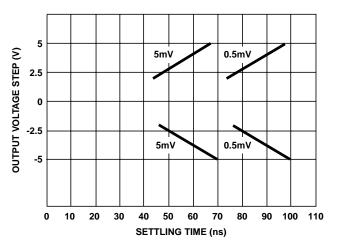


FIGURE 14. SETTLING TIME FOR VARIOUS OUTPUT STEP VOLTAGES

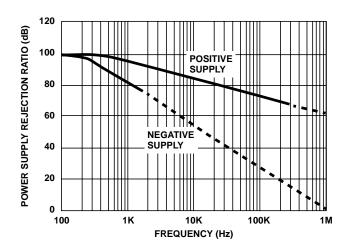


FIGURE 16. POWER SUPPLY REJECTION RATIO vs FREQUENCY

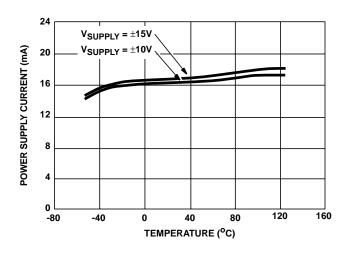


FIGURE 17. POWER SUPPLY CURRENT vs TEMPERATURE

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#### HA-5190, HA-5195

#### Die Characteristics

#### **DIE DIMENSIONS:**

54 mils x 88 mils x 19 mils 1360μm x 2240μm x 483μm

#### **METALLIZATION:**

Type: AI, 1% Cu Thickness: 16kÅ ±2kÅ

#### **PASSIVATION:**

Type: Nitride (Si<sub>3</sub>N<sub>4</sub>) over Silox (SiO<sub>2</sub>, 5% Phos.)

Silox Thickness: 12kÅ ±2kÅ Nitride Thickness: 3.5kÅ ±1.5kÅ

# SUBSTRATE POTENTIAL (Powered Up):

V-

#### TRANSISTOR COUNT:

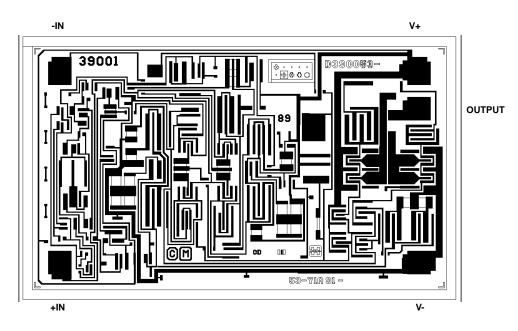
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#### PROCESS:

**Bipolar Dielectric Isolation** 

# Metallization Mask Layout

HA-5190



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